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| Search Notes  | Application/Control No. 10766869 | Applicant(s)/Patent Under Reexamination UMEZAWA ET AL. |
| | Examiner Paliwal, Yogesh | Art Unit 2135 |

| SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
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| SEARCH NOTES | | |
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| Search Notes | Date | Examiner |
| Inventor name search in east+Google+IEEE | 5/23/2007 | YP |
| (713/156-158) + Keywords -See search history printout | 5/24/2007 | YP |
| (713.CLAS) + Keywords - See search history printout | 5/24/2007 | YP |
| (726/9) + Keywords - See search history printout | 5/24/2007 | YP |
| (713/175) + Keyword - See search history printout | 5/24/2007 | YP |
| (705/65-69) + Keyword - See search history printout | 5/24/2007 | YP |
| (713/172-174) + Keyword -See search history printout | 5/24/2007 | YP |
| (&26/10) + Keyword -See search history printout | 5/24/2007 | YP |
| NPL search (Done by STIC) | 3/14/2007 | YP |
| Database search - IEEE - See search history printout | 5/24/2007 | YP |
| Database search - Dialog - See search history printout | 5/24/2007 | YP |

| INTERFERENCE SEARCH | | | |
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